

30 V, 3.5 A NPN low V_{CEsat} (BISS) transistor Rev. 01 — 30 January 2010

Product data sheet

Product profile 1.

1.1 General description

NPN low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a SOT457 (SC-74) small Surface-Mounted Device (SMD) plastic package.

PNP complement: PBSS4032PD.

1.2 Features

- Low collector-emitter saturation voltage V_{CEsat}
- Optimized switching time
- High collector current capability I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- High energy efficiency due to less heat generation
- AEC-Q101 qualified
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

1.3 Applications

- DC-to-DC conversion
- Battery-driven devices
- Power management
- Charging circuits

1.4 Quick reference data

Table 1. **Quick reference data**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage	open base	-	-	30	V
l _C	collector current		-	-	3.5	А
I _{CM}	peak collector current	single pulse; $t_p \leq 1 \text{ ms}$	-	-	6	A
R _{CEsat}	collector-emitter saturation resistance	I _C = 4 A; I _B = 400 mA	<u>[1]</u> -	50	75	mΩ

[1] Pulse test: $t_p \le 300 \ \mu s$; $\delta \le 0.02$.



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2. Pinning information

	Description				
Pin	Description	Simplified outline	Graphic symbol		
1	collector				
2	collector		1, 2, 5, 6		
3	base	0	з —		
4	emitter				
5	collector		4 sym014		
6	collector				

3. Ordering information

Table 3. Order	ing informa	tion	
Type number	Package		
	Name	Description	Version
PBSS4032ND	SC-74	plastic surface-mounted package; 6 leads	SOT457

4. Marking

Table 4. Ma	rking codes	
Type number		Marking code
PBSS4032ND		ZF

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CBO}	collector-base voltage	open emitter	-	30	V
V _{CEO}	collector-emitter voltage	open base	-	30	V
V _{EBO}	emitter-base voltage	open collector	-	5	V
I _C	collector current		-	3.5	А
I _{CM}	peak collector current	single pulse; $t_p \leq 1 ms$	-	6	A
I _B	base current		-	0.5	А

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Table 5.	Limiting va	alues continued
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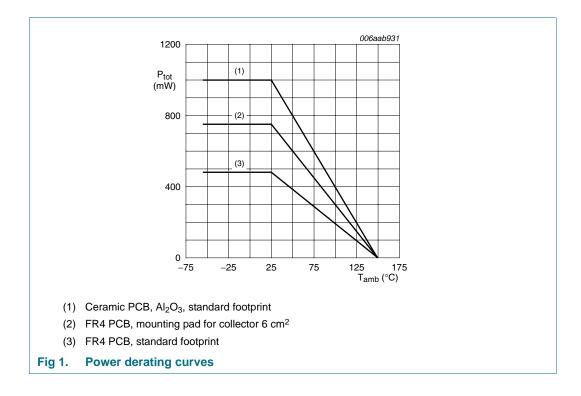
In accordance with the Absolute Maximum Rating System (IEC 60134).

				-		
Symbol	Parameter	Conditions		Min	Max	Unit
P _{tot}	total power dissipation	$T_{amb} \le 25 \ ^\circ C$	[1]	-	480	mW
			[2]	-	750	mW
			[3]	-	1	W
Tj	junction temperature			-	150	°C
T _{amb}	ambient temperature			-55	+150	°C
T _{stg}	storage temperature			-65	+150	°C

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².

[3] Device mounted on a ceramic PCB, AI_2O_3 , standard footprint.



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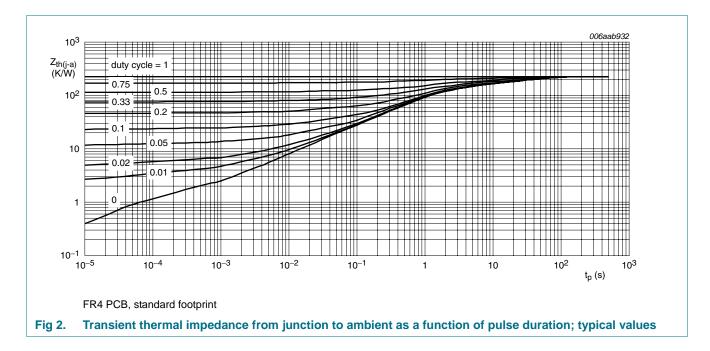
6. Thermal characteristics

Table 6.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	<u>[1]</u> _	-	260	K/W
			[2] _	-	160	K/W
			<u>[3]</u> _	-	125	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point		-	-	45	K/W

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².

[3] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.

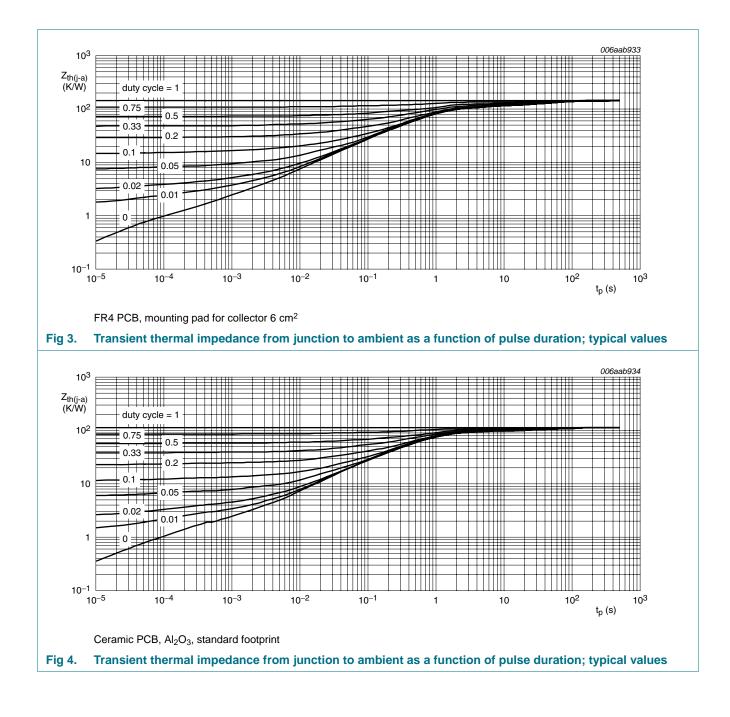


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7. Characteristics

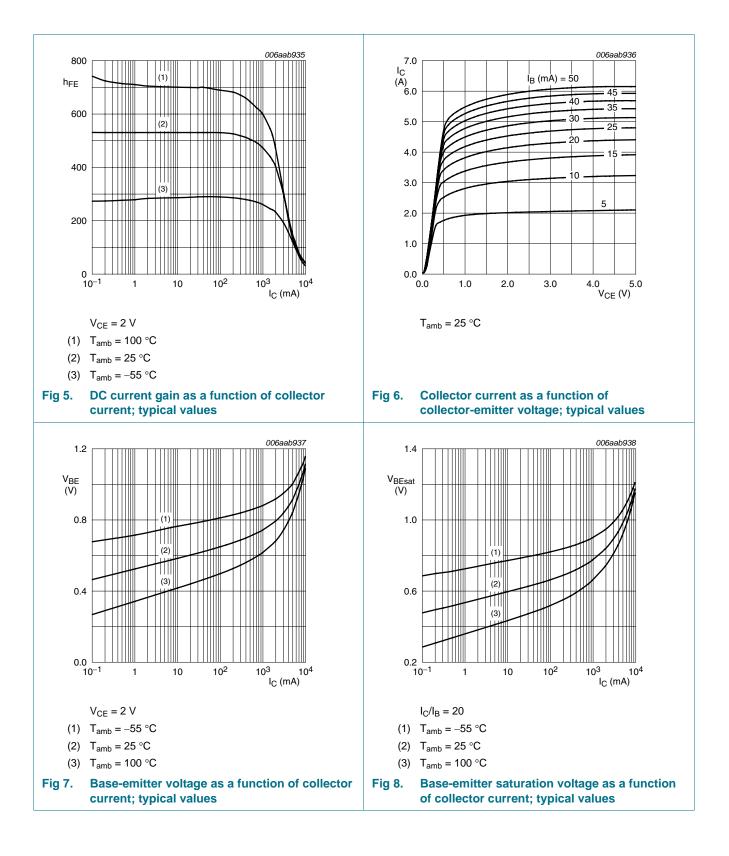
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = 30 \text{ V}; I_E = 0 \text{ A}$		-	-	100	nA
	current	$V_{CB} = 30 \text{ V}; I_E = 0 \text{ A};$ T _j = 150 °C		-	-	50	μΑ
I _{CES}	collector-emitter cut-off current	$V_{CE} = 24 \text{ V}; V_{BE} = 0 \text{ V}$		-	-	100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; \text{ I}_{C} = 0 \text{ A}$		-	-	100	nA
h _{FE}	DC current gain	$V_{CE} = 2 \text{ V}; I_{C} = 500 \text{ mA}$	[1]	300	500	-	
		$V_{CE} = 2 \text{ V}; \text{ I}_{C} = 1 \text{ A}$	[1]	300	460	-	
		$V_{CE} = 2 \text{ V}; \text{ I}_{C} = 2 \text{ A}$	[1]	250	400	-	
		$V_{CE} = 2 V; I_C = 4 A$	[1]	120	200	-	
		$V_{CE} = 2 V; I_C = 6 A$	[1]	60	100	-	
V _{CEsat}	collector-emitter	$I_{C} = 500 \text{ mA}; I_{B} = 50 \text{ mA}$	[1]	-	70	100	mV
saturat	saturation voltage	I _C = 1 A; I _B = 50 mA	[1]	-	110	155	mV
		$I_{C} = 1 \text{ A}; I_{B} = 10 \text{ mA}$	[1]	-	155	220	mV
		$I_{C} = 2 \text{ A}; I_{B} = 40 \text{ mA}$	[1]	-	180	250	mV
		I _C = 3 A; I _B = 300 mA	[1]	-	180	250	mV
		$I_{C} = 4 \text{ A}; I_{B} = 400 \text{ mA}$	[1]	-	200	300	mV
R _{CEsat}	collector-emitter saturation resistance	$I_{C} = 4 \text{ A}; I_{B} = 400 \text{ mA}$	[1]	-	50	75	mΩ
V _{BEsat}	base-emitter	$I_{C} = 1 \text{ A}; I_{B} = 100 \text{ mA}$	[1]	-	0.78	0.9	V
	saturation voltage	I _C = 3 A; I _B = 300 mA	[1]	-	0.98	1.1	V
V _{BEon}	base-emitter turn-on voltage	$V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}$		-	0.79	0.85	V
t _d	delay time	V_{CC} = 12.5 V; I _C = 1 A;		-	23	-	ns
t _r	rise time	$I_{Bon} = 0.05 \text{ A};$		-	25	-	ns
t _{on}	turn-on time	$I_{Boff} = -0.05 \text{ A}$		-	48	-	ns
t _s	storage time			-	140	-	ns
t _f	fall time			-	65	-	ns
t _{off}	turn-off time			-	205	-	ns
f _T	transition frequency	V _{CE} = 10 V; I _C = 100 mA; f = 100 MHz		-	135	-	MHz
C _c	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz		-	44	-	pF

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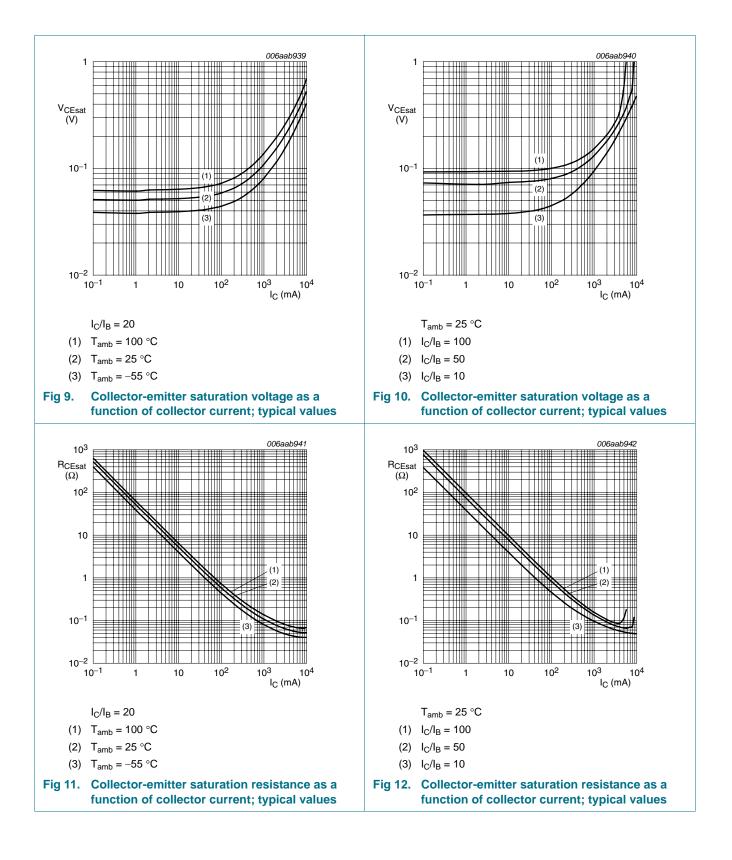


PBSS4032ND_1 Product data sheet

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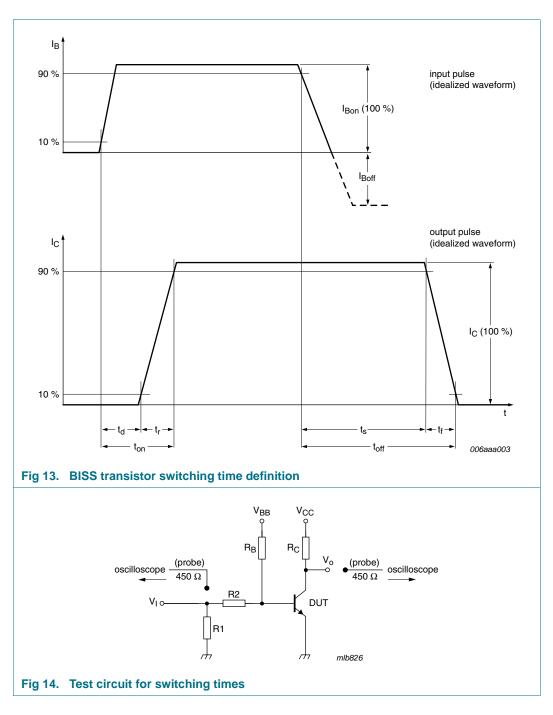
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8. Test information



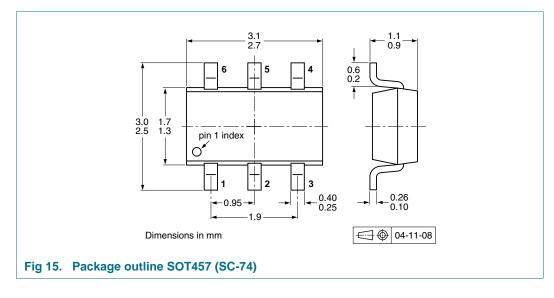
8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101* - *Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

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9. Package outline



10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Type number Package Description			Packing o	uantity
				3000	10000
PBSS4032ND SOT457	4 mm pitch, 8 mm tape and reel	[2]	-115	-135	
		4 mm pitch, 8 mm tape and reel	[3]	-215	-235

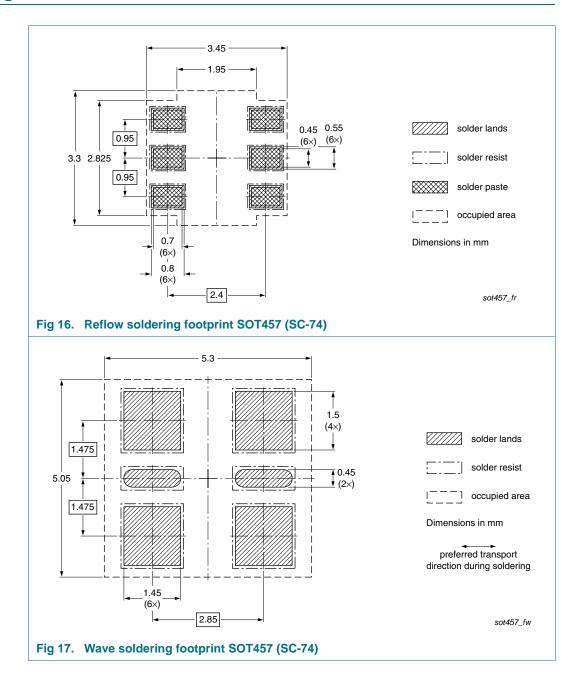
[1] For further information and the availability of packing methods, see <u>Section 14</u>.

[2] T1: normal taping

[3] T2: reverse taping

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11. Soldering



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12. Revision history

Table 9. Revision hist	ory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS4032ND_1	20100130	Product data sheet	-	-

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13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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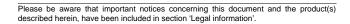
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Product data sheet

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